## **Lynn Conway**

Born January 2, 1938, Mt. Vernon, N. Y; Xerox Parc (Palo Alto Research Center) researcher who with Carver Mead created a radically new way of designing chips.

Education: BS, Columbia University, 1962; MSEE, Columbia University, 1963.

Professional Experience: member, research staff, computer architecture, IBM Corp., 1964-1969; senior staff engineer, Memorex Corp., 1969-1973; Xerox Palo Alto Research Center: member, research staff, Digital Systems Architecture, 1973-1977; manager, LST Systems Area, 1977-1980; research fellow and manager, VLSI System Design Area, 1980-present

## **UPDATES**

A complete description of Lynn Conway is available <a href="here">here</a>. (MRW. 2012)